



**N-channel Enhancement-mode Power MOSFET**

- Low On-resistance**
- Simple Drive Requirement**
- Fast Switching Characteristics**
- RoHS-compliant, halogen-free**

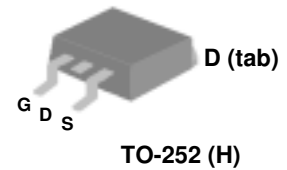


$BV_{DSS}$	60V
$R_{DS(ON)}$	6mΩ
$I_D$	100A

**Description**

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, low on-resistance and cost-effectiveness.

The AP9990GH-HF-3 is in the TO-252 package, which is widely used for commercial and industrial surface-mount applications, and is well suited for low voltage applications such as DC/DC converters.



**Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	60	V
$V_{GS}$	Gate-Source Voltage	±20	V
$I_D$ at $T_c=25^\circ\text{C}$	Continuous Drain Current (Silicon limited)	100	A
$I_D$ at $T_c=25^\circ\text{C}$	Continuous Drain Current (Package limited)	75	A
$I_D$ at $T_c=100^\circ\text{C}$	Continuous Drain Current	70	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	300	A
$P_D$ at $T_c=25^\circ\text{C}$	Total Power Dissipation	125	W
$P_D$ at $T_A=25^\circ\text{C}$	Total Power Dissipation	2.4	W
$T_{STG}$	Storage Temperature Range	-55 to 175	°C
$T_J$	Operating Junction Temperature Range	-55 to 175	°C

**Thermal Data**

Symbol	Parameter	Value	Unit
Rthj-c	Maximum Thermal Resistance, Junction-case	1.2	°C/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient (PCB mount) <sup>3</sup>	62.5	°C/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient	110	°C/W

**Ordering Information**

**AP9990GH-HF-3TR** : in RoHS-compliant halogen-free TO-252, shipped on tape and reel (3000 pcs/reel)



**Electrical Specifications at  $T_j=25^\circ\text{C}$  (unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	60	-	-	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{GS}=10V, I_D=40A$	-	-	6	m $\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2	-	5	V
$g_{fs}$	Forward Transconductance	$V_{DS}=10V, I_D=40A$	-	55	-	S
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=48V, V_{GS}=0V$	-	-	25	$\mu A$
$I_{GSS}$	Gate-Source Leakage	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA
$Q_g$	Total Gate Charge <sup>2</sup>	$I_D=40A$	-	59	94	nC
$Q_{gs}$	Gate-Source Charge	$V_{DS}=48V$	-	14	-	nC
$Q_{gd}$	Gate-Drain ("Miller") Charge	$V_{GS}=10V$	-	30	-	nC
$t_{d(on)}$	Turn-on Delay Time <sup>2</sup>	$V_{DS}=30V$	-	14	-	ns
$t_r$	Rise Time	$I_D=40A$	-	76	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=1\Omega$	-	25	-	ns
$t_f$	Fall Time	$V_{GS}=10V$	-	12	-	ns
$C_{iss}$	Input Capacitance	$V_{GS}=0V$	-	2320	3700	pF
$C_{oss}$	Output Capacitance	$V_{DS}=25V$	-	450	-	pF
$C_{rss}$	Reverse Transfer Capacitance	$f=1.0\text{MHz}$	-	280	-	pF
$R_g$	Gate Resistance	$f=1.0\text{MHz}$	-	1.3	2.6	$\Omega$

**Source-Drain Diode**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_{SD}$	Forward On Voltage <sup>2</sup>	$I_S=40A, V_{GS}=0V$	-	-	1.3	V
$t_{rr}$	Reverse Recovery Time <sup>2</sup>	$I_S=10A, V_{GS}=0V,$	-	45	-	ns
$Q_{rr}$	Reverse Recovery Charge	$dI/dt=100A/\mu s$	-	70	-	nC

**Notes:**

1. Pulse width limited by Max. junction temperature.
2. Pulse test
3. Package limitation current is 75A.
4. Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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Typical Electrical Characteristics

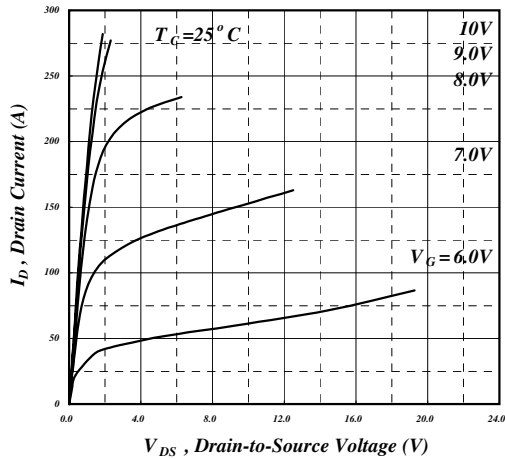


Fig 1. Typical Output Characteristics

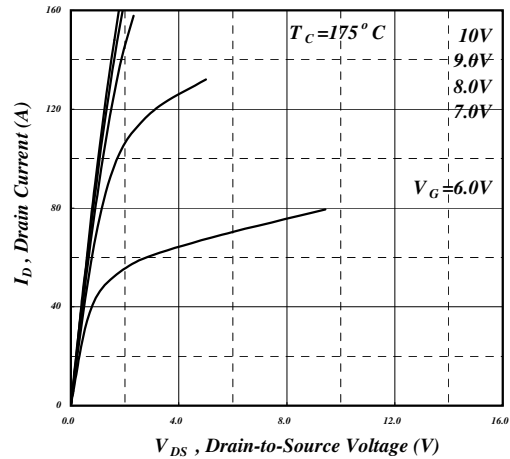


Fig 2. Typical Output Characteristics

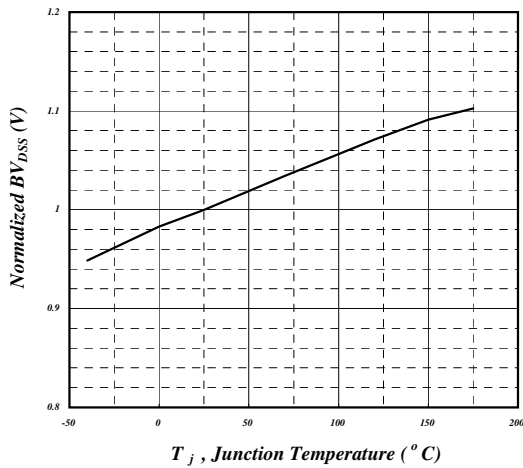


Fig 3. Normalized BVDSS vs. Junction Temperature

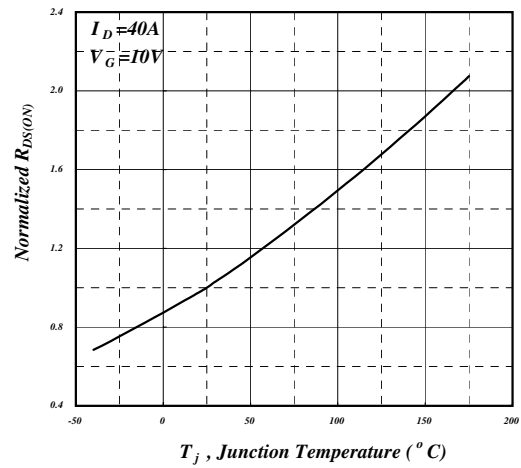


Fig 4. Normalized On-Resistance vs. Junction Temperature

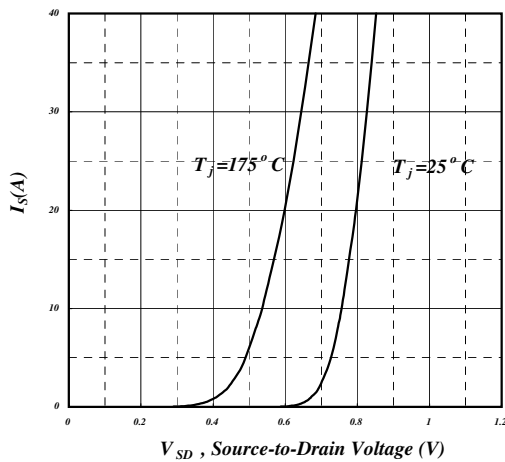


Fig 5. Forward Characteristic of Reverse Diode

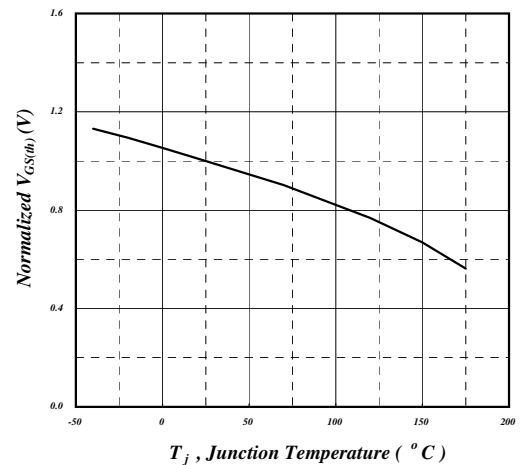


Fig 6. Gate Threshold Voltage vs. Junction Temperature



Typical Electrical Characteristics (cont.)

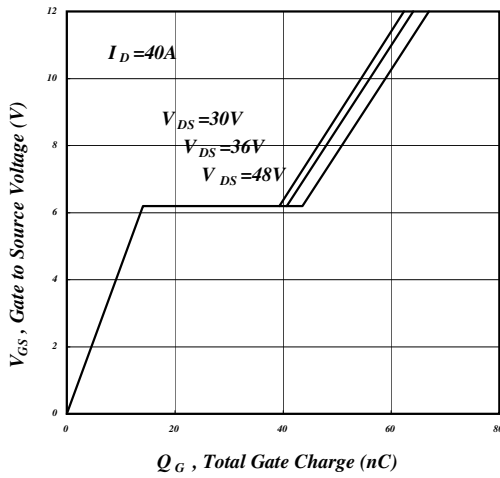


Fig 7. Gate Charge Characteristics

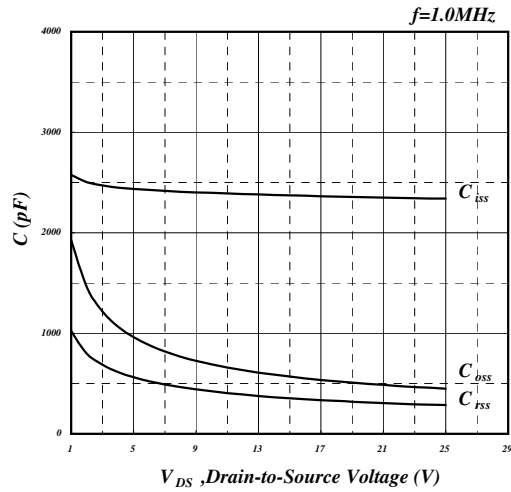


Fig 8. Typical Capacitance Characteristics

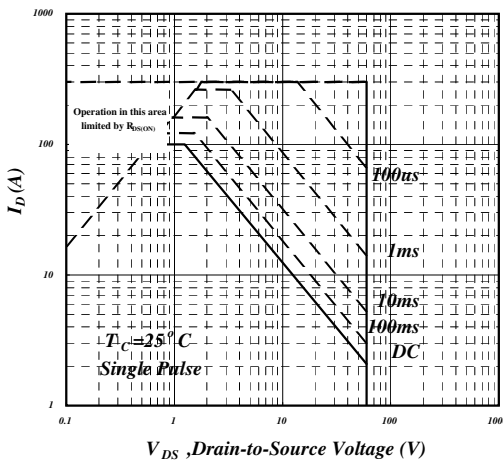


Fig 9. Maximum Safe Operating Area

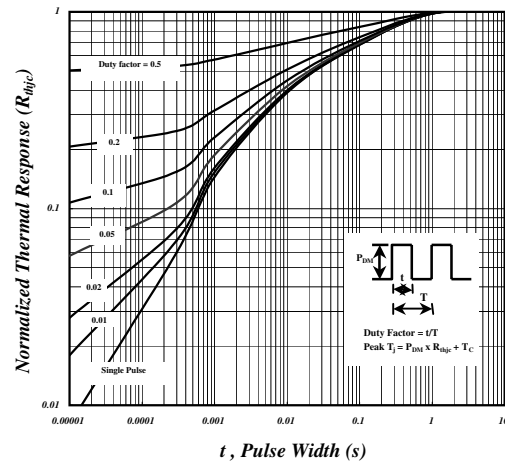


Fig 10. Effective Transient Thermal Impedance

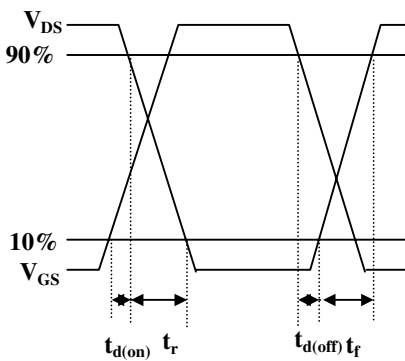


Fig 11. Switching Time Waveforms

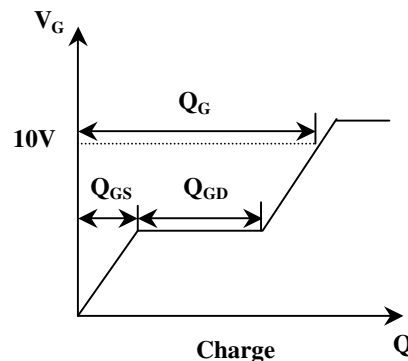
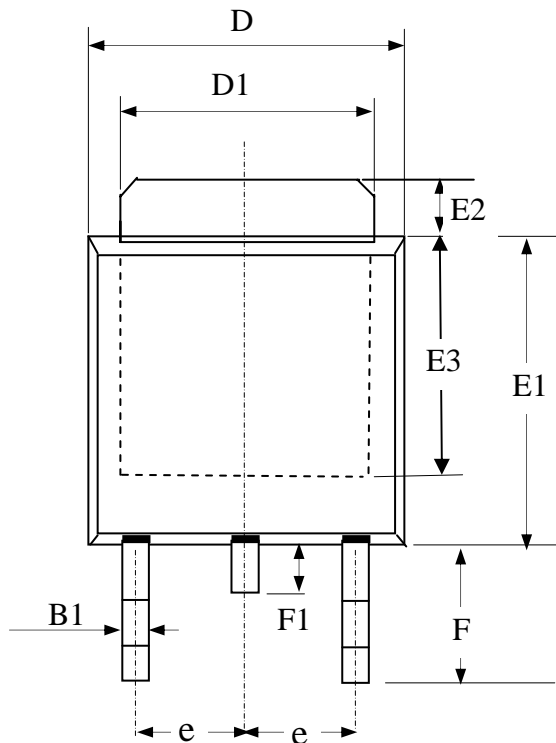


Fig 12. Gate Charge Waveform

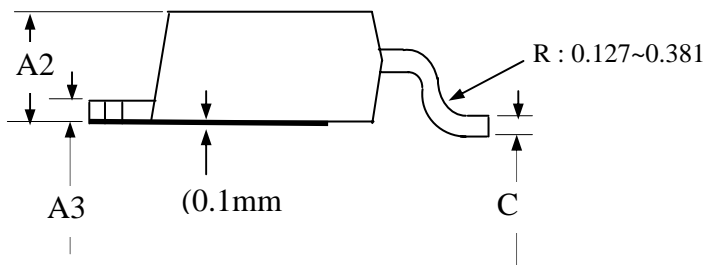


**Package Dimensions: TO-252**



SYMBOLS	Millimeters		
	MIN	NOM	MAX
A2	1.80	2.30	2.80
A3	0.40	0.50	0.60
B1	0.40	0.70	1.00
D	6.00	6.50	7.00
D1	4.80	5.35	5.90
E3	3.50	4.00	4.50
F	2.20	2.63	3.05
F1	0.50	0.85	1.20
E1	5.10	5.70	6.30
E2	0.50	1.10	1.80
e	--	2.30	--
C	0.35	0.50	0.65

1. All dimensions are in millimeters.
2. Dimensions do not include mold protrusions.



**Marking Information:**

Laser Marking

